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Research Article

Hydrothermal Growth of Titanium Dioxide Thin Films on Conductive Substrates: Insights into Optical Properties

Yulia Eka Putri^{1*}, Tio Putra Wendari¹, Retno Dyah Wulandari¹, Melvi Muharmi², Mai Efdi¹, Refinel Refinel¹

¹Department of Chemistry, Faculty of Mathematics and Natural Sciences, Universitas Andalas, Padang (25163), Indonesia

²Chemical Analyst Study Program, Department of Mathematics and Natural Sciences, Faculty of Science and Technology, Universitas Jambi, Muaro Jambi. 35361, Indonesia

*Email: yuliaekaputri@sci.unand.ac.id

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Abstract

Titanium dioxide (TiO₂) thin films were deposited on fluorine-doped tin oxide (F:SnO₂/FTO) conducting glass using the hydrothermal method. The X-ray diffraction (XRD) patterns confirmed that the TiO2 thin films crystallize in the rutile phase, exhibiting high crystallinity. The Fourier Transform Infrared (FTIR) spectrum confirmed the interaction between the FTO substrate and the TiO₂ layer, indicated by an absorption peak in the range of 400 cm⁻¹ to 900 cm⁻¹. These peaks correspond to Ti-O-Ti and Ti-O vibrations within the octahedral structure of TiO6 and Sn-O-Ti vibrations, indicating the bonding between the FTO substrate and the TiO2 surface. Scanning Electron Microscopy (SEM) images provide detailed visualization of the morphological features of the TiO2 thin films deposited on FTO glass, as evidenced by the prolonged hydrothermal processing resulting in the formation of thicker films. In addition, the interface between the TiO2 layer and the FTO substrate is well-defined and continuous. UV-Visible Diffuse Reflectance Spectroscopy (UV-Vis DRS) analysis showed enhanced light absorption with increasing film thickness, which was also visually noticeable. As a result, the band gap energy decreases with increasing thickness, indicating that less energy is required to excite electrons from the valence band to the conduction band.

Keywords: Hydrothermal, rutile, thin film, TiO₂

1. INTRODUCTION

Nanotechnology represents a cutting-edge realm involving materials scaled down to dimensions ranging from 1 to 100 nanometers, exhibiting unique chemical and physical properties superior to bulk materials ¹. Nanomaterials are categorized based on their dimensions into 1D, 2D, and 3D structures, with 2D nanomaterials currently garnering significant attention for their potential in nanotechnological innovations ². Among these dimensions, 2D thin films stand out as a prominent example. The development of 2D thin films aims to harness materials with advanced functionalities, including transistors ³, photocatalysts ⁴, coatings for self-cleaning ⁵, batteries ⁶, sensors ⁷, and implants ⁸.

One of the 2D compounds that has attracted attention as a thin film is titanium dioxide (TiO₂). TiO₂ is gaining attention as a promising material for thin films due to its semiconductor properties, high surface area and surface reactivity, thermal stability, non-toxicity, eco-friendliness, and abundance in nature. It has demonstrated excellent performance in various applications such as photocatalysis, dye degradation, solar cells, self-cleaning surfaces, smart windows, anti-fogging coatings, and photochromic materials 9. TiO₂ thin films can be deposited on both non-conductive substrates like glass and conductive substrates, such as indium tin oxide (ITO), fluorine tin oxide (FTO), silicon wafers, and metal oxides. Studies have reported that the presence of tin oxide (SnO₂) layer on the glass substrate serves as a favorable

nucleation site during the growth of TiO₂ ¹⁰. FTO glass stands out as a highly efficient substrate choice due to its excellent chemical and thermal stability, superior mechanical strength, and cost-effectiveness. Moreover, the optical characteristics of the TiO₂ thin film on the FTO glass substrate exhibit significant UV-Vis absorption capabilities, rendering it a promising contender for harnessing solar photons in photoelectrochemical applications ¹¹.

A number of methods have been utilized to produce TiO₂ thin films, including physical techniques such as dip coating, chemical vapor deposition (CVD), physical vapor deposition (PVD), pulsed laser deposition (PLD), and magnetron sputtering, as well as chemical methods like electrochemistry and hydrothermal synthesis. Among these, hydrothermal method stands out for its simplicity, relatively low synthesis temperature, and equipment accessibility, making it suitable for thin film fabrication on specific substrates ¹². Therefore, in this study, we employed the hydrothermal technique to synthesize TiO2 thin films on FTO substrates with varying synthesis times. Variation in synthesis time affects parameters such as crystal growth, particle size, film thickness, and surface morphology, which in turn affect the structural and optical properties of the resulting thin films. Therefore, optimizing the deposition process and obtaining films with desired crystallinity and thickness play a crucial role in determining their functional properties. Furthermore, FTO substrates were chosen for their long-term stability, high mechanical strength, good film adhesion under normal and high-temperature conditions, and the requirement for a flat and smooth surface to prevent chemical reactions from altering film properties. The resulting TiO2 thin films were characterized to investigate their crystal structure, surface interactions, and optical properties.

2. RESEARCH METHODS

The materials used in this study included titanium (IV) butoxide (TBOT) from Sigma-Aldrich, ethanol from Merck, hydrochloric acid 36.5~38% (HCl) from Merck, deionized water, and FTO glass. All materials were utilized without undergoing further purification, and the dimension of FTO glass used in the samples varies in length and width; however, all samples have the same FTO thickness of 3 mm. The equipment utilized for characterization were: X-Ray Diffraction (XRD-PANalytical), Fourier Transform Infrared (FTIR-PerkinElmer), Scanning Electron Microscope (SEM-Carl Zeiss EXO 10), and Diffuse Reflectance Spectroscopy UV-Vis (DRS UV-Vis-Analytik Jena Specord 210).

FTO substrates were prepared by rinsing and sonicating in distilled water and ethanol for 15 minutes each, followed by air-drying the clean FTO glass. For

the TiO₂ solution preparation, 17.1428 mL of 37% HCl was dissolved in 17.1428 mL of deionized water with stirring for 10 minutes. Once the solution became homogeneous, 0.7143 mL of titanium (IV) butoxide was added dropwise while stirring for an additional 10 minutes. The resulting clear solution was then transferred into a Teflon-lined autoclave. Subsequently, the FTO glass was positioned vertically within the autoclave. The hydrothermal process was conducted at 150 °C for durations of 3, 5, and 8 hours. After the hydrothermal treatment, the TiO2-coated substrate was dried at room temperature. The TiO₂ thin film samples were designated as TLF-3, TLF-5, and TLF-8, respectively. Characterization of the TiO₂ thin films was carried out using XRD, FTIR, SEM, and DRS UV-Vis.

3. RESULTS AND DISCUSSION

Hydrothermal synthesis of TiO₂ thin films used titanium (IV) butoxide (TBOT) as the Ti precursor, hydrochloric acid (HCl) as the catalyst, and deionized water as the solvent. The synthesis involved varying synthesis times of 3 hours, 5 hours, and 8 hours on an FTO glass substrate. The visual appearance of the post-synthesis samples is shown in **Figure 1**. The FTO size differed among the samples, resulting in varying surface areas for deposition; however, this variation did not affect the synthesis process, particularly during the nucleation and crystal growth stages. As the hydrothermal reaction time increases, the TiO2 film becomes thicker due to the higher particle density. Extended synthesis times promote grain growth and improve crystallinity, which helps reduce lattice defects and lowers the band gap energy. Subsequently, the synthesis duration affects not only the film thickness and transparency but also its structural order and optical characteristics 13.

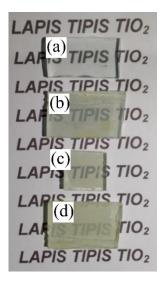


Figure 1. The physical appearance of the TiO_2 thin film samples. (a) FTO glass substrate, (b) TLF-3, (c) TLF-5, and (d) TLF-8

The reaction mechanism for TiO₂ formation initiates with a hydrolysis process in an acidic environment. Here, the lone electron pair of the oxygen atom in titanium butoxide interacts with a hydrogen ion from the hydronium ion, generating the oxygen atom to have a positive charge, resulting electron deficiency. Subsequently, the lone electron pair of the oxygen atom in a water molecule attacks the titanium atom, leading to the release of butanol and the formation of titanium hydroxide (Ti(OH)₄). Next, the lone pair of electrons on the oxygen atom within the Ti-OH bond reacts with a hydrogen atom from hydrochloric acid (HCl), generating a protonated oxygen atom. This protonated oxygen atom is further deprotonated with the assistance of the chloride ion, which facilitates the condensation process and results in the formation of water molecules. Finally, this condensation process finishes in the creation of TiO₂ compounds (controlled structure and growth mechanism ¹⁴. The synthesis reactions can be explained as follows:

Hydrolysis $Ti(OC_4H_9)_4 + 4H_2O \rightarrow Ti(OH)_4 + 4C_4H_9OH$ Dehydration $Ti(OH)_4 + Ti(OH)_4 \rightarrow TiO_2 + 2H_2O$

The XRD patterns of the TiO₂ thin film, as shown in Figure 2, show the peak positions and relative intensities of the TiO2 crystal structure compared with the standard ICSD database. The XRD pattern reveals diffraction peaks at 2θ angles of 27.43°, 36.17°, 41.27°, 54.44°, and 62.80° with corresponding hkl values of (110), (101), (111), (211), and (002), respectively. These peaks signify that the TiO₂ thin layer is in the rutile phase, possessing a tetragonal structure (ICSD #109469). Additionally, the XRD pattern exhibits diffraction peaks corresponding to SnO₂ in all three samples (ICSD #157448) as the substrate ¹⁵. In the TLF-3 sample, the intensity of the SnO₂ diffraction peak surpasses that of the TiO₂; however, the peak intensity of the TiO₂ at the (110) crystal plane increases further in samples TLF-5 and TLF-8. This increase suggests that the thermal energy during the hydrothermal process is insufficient for substantial growth of the TiO₂ layer on the FTO glass substrate, indicating that the TiO2 layer formed on the TLF-3 sample remains too thin ¹⁶. Conversely, the SnO₂ diffraction peak in samples TLF-5 and TLF-8 exhibits lower intensity compared to the TiO₂ peak. This observation implies that the extended duration in the hydrothermal process provides additional energy to TiO2 atoms, facilitating complete crystal growth and enhancing the arrangement of crystal planes.

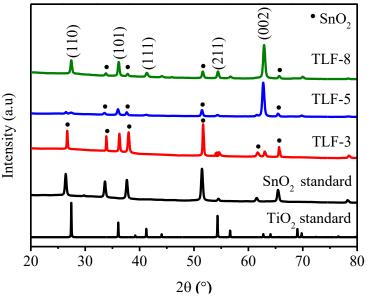


Figure 2. The XRD patterns of the TiO₂ thin film samples

The FTIR spectrum displayed in **Figure 3** provides the identification of functional groups in the TiO₂ thin films by analyzing peaks associated with particular vibrational modes. The results do not exhibit significant differences in peak patterns for TiO₂ thin films synthesized with varying hydrothermal process times. The absorption peaks within the range of 400 cm⁻¹ to 900 cm⁻¹ were attributed to the presence of

TiO₆ octahedra, indicating the formation of TiO₂ compound. The weak absorption peak at 1100 cm⁻¹ indicates the stretching vibration of the silanol and siloxane groups, originating from the glass substrate. The peaks in the range of 400 to 500 cm⁻¹ can be ascribed to the stretching and bending modes of Ti-O-Ti in all three TiO₂ samples ¹⁷. Moreover, the vibration mode observed at 560 cm⁻¹ indicates the interaction

between Ti–O–Ti and Sn-O-Ti, implying a potential interaction between SnO₂ and the TiO₂ thin film ^{18,19}. The Si–O stretching vibration detected in the FTIR spectrum likely originates from the underlying silica glass substrate. This vibration does not indicate a direct chemical reaction affecting the TiO₂ deposition process but rather reflects the substrate's inherent

composition. However, during the hydrothermal synthesis, limited interfacial diffusion of Si species into the TiO₂ layer may occur, potentially enhancing interfacial bonding and adhesion between the film and the substrate. Such interdiffusion can improve film stability without significantly altering the TiO₂ lattice structure.

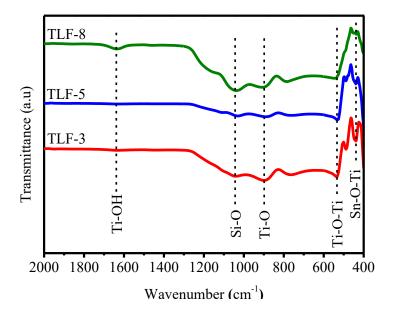


Figure 3. The FTIR spectrum of the TiO₂ thin film samples

SEM image analysis confirms the successful formation of TiO2 on the FTO substrate via the hydrothermal method. The images shown in Figure 4 provide valuable insights into the structural and morphological characteristics of TiO2 thin films deposited on FTO glass substrates hydrothermal method. Morphological characterization was carried out on TLF-8 sample, as XRD analysis showed that this sample exhibited diffraction peaks with the highest intensity. In contrast, the TLF-3 and TLF-5 samples showed weaker diffraction patterns. Figure 4(a) shows a cross-sectional view of the FTO glass, clearly showing a uniform and smooth layer with a measured thickness of approximately 900 nm, and Figure 4(b) displays the top view of the smooth and compact surface, indicating the regularities of FTO particles. A cross-sectional image of the TLF-8 sample (Figure 4(c)) shows a thick TiO₂ layer deposited on the FTO substrate. The TiO2 layer is measured to be around 15 µm, indicating substantial film growth with a dense structure. The interface between the TiO2 and FTO is distinct but continuous, suggesting good adhesion between the two layers, as evidenced by an absorption band at 560 cm⁻¹ in the FTIR spectrum. The top-view image (Figure 4(d)) shows a textured, rough, and uneven surface, with visible grains and possible agglomerates, indicating a non-uniform but continuous deposition of TiO2 over the substrate.

The analysis conducted using Reflectance Spectroscopy UV-Vis aims to ascertain the band gap energy of semiconductor materials when exposed to UV light. The optical absorption measurements using DRS UV-Vis, conducted within the wavelength range of 300–400 nm for all samples as depicted in Figure 5 (inset), show absorption peaks in the ultraviolet wavelength region. Within this range, the resulting TiO₂ thin layer tends to absorb most incoming light, resulting in high absorption values ²⁰. The prepared samples of TLF-3, TLF-5, and TLF-8 demonstrate that as the hydrothermal time increases, the thickness of the layer visibly increases, resulting in reduced transparency. This phenomenon occurs because thicker layers grown on the glass substrate possess a higher density of constituent atoms, leading to increased photon collisions and greater difficulty for light rays to penetrate through ²¹.

The Eg value was estimated by a classical extrapolation approach according to: $(\alpha h \upsilon) = \beta$ ($h \upsilon - Eg)^{1/2}$, where α is the absorption coefficient being a fuction of wavelength (cm⁻¹), h is the Planck's constant (J.s), υ is the frequency of the photon energy, β is a constant, and Eg is the band gap energy (eV). As shown in **Figure 5**, the samples TLF-3, TLF-5, and TLF-8 exhibit band gap energy values, namely 3.11

eV, 3.14 eV, and 3.05 eV, respectively. This suggests a correlation between the absorption value and the resulting band gap energy ²². According to the Tauc Plot method formula, the absorption is inversely proportional to the band gap energy value, indicating that higher absorption values correspond to smaller

band gap energies. A smaller band gap energy implies that lower energy is required to excite electrons from the valence band to the conduction band, a consequence of the increased thickness of the TiO₂ thin layer produced via the hydrothermal process ²³.

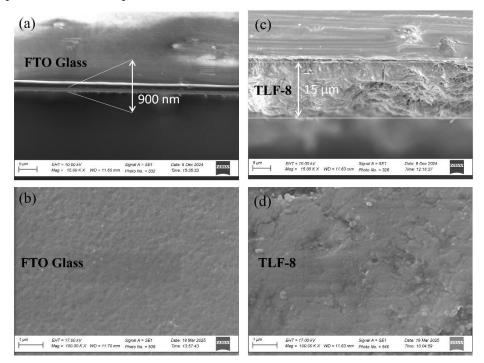


Figure 4. SEM images of TiO₂ thin film samples, (a,c) cross-section, and (c,d) surface of the pellet samples

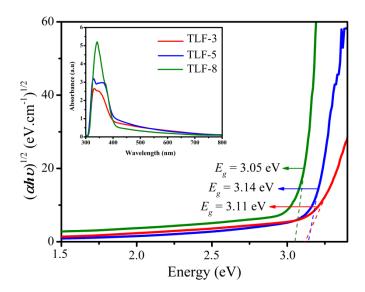


Figure 5. (a) DRS absorption region of the TLF samples, and (b) the plots of $(\alpha h v^{1/2})$ vs hv for the determination of the optical band gap of TiO₂ thin film

Furthermore, the Eg values of all samples are nearly identical to the band gap energy of rutile phase TiO_2 in bulk form, which is 3.02 eV. This suggests that the TLF-3 and TLF-5 samples are still outside the nanometer thickness range. The optical properties may degrade when the film thickness exceeds the

nanometer scale, as a result of enhanced light absorption and scattering, which reduces transparency. Furthermore, excessive thickness can influence the crystallinity, ultimately leading to a decline in the overall structural quality of the film. The strong interface bonding and substantial film thickness

indicate that the hydrothermal method is potentially suitable for scalable thin film fabrication.

The TLF-5 sample exhibits the highest band gap value (3.14 eV), which can be attributed to incomplete crystal growth. Such structural features lead to localized lattice disorder and possible quantum confinement effects, both of which contribute to a widening of the band gap value. In contrast, the TLF-8 sample, which possesses greater thickness and improved crystallinity, shows a smaller band gap (3.05 eV), approaching the value of bulk rutile TiO₂ (3.02 eV). This trend explains that as the film becomes thicker and more structurally ordered, the band gap narrows due to reduced lattice defects.

4. CONCLUSIONS

The synthesis of TiO₂ thin films via the hydrothermal method at 150 °C with different heating durations of 3, 5, and 8 hours, leading to the formation of the rutile phase. This interpretation is supported by the XRD pattern analysis, which shows peak correspondence with the standard rutile phase of TiO₂. Additionally, the XRD pattern indicated that the TLF-8 sample exhibited higher crystallinity compared to the TLF-3 and TLF-5 samples. The FTIR spectrum revealed the interaction between the FTO substrate and the TiO₂ thin layer through specific absorption features. Furthermore, UV-Vis DRS analysis confirmed that increasing the film thickness enhances its light absorption. UV-Vis DRS analysis confirmed that increasing the film thickness enhances its light absorption, which aligns with visual observations; as a result, the band gap energy values of the samples demonstrate a decreasing trend. A smaller band gap energy implies a lower energy requirement for exciting electrons from the valence band to the conduction band. This phenomenon is attributed to the greater film thickness of the TLF-8 sample hydrothermal synthesized via processing, evidenced by the SEM images.

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